# Power MOSFET -3.05 Amps, -30 Volts

#### P-Channel SOIC-8

#### **Features**

- High Efficiency Components in a Single SOIC-8 Package
- High Density Power MOSFET with Low R<sub>DS(on)</sub>
- Miniature SOIC-8 Surface Mount Package Saves Board Space
- Diode Exhibits High Speed with Soft Recovery
- I<sub>DSS</sub> Specified at Elevated Temperature
- Avalanche Energy Specified
- Mounting Information for the SOIC-8 Package is Provided
- Pb-Free Package is Available

#### **Applications**

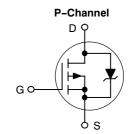
- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery-Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular & Cordless Telephones



#### ON Semiconductor®

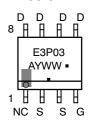
http://onsemi.com

-3.05 AMPERES -30 VOLTS 0.085  $\Omega$  @ V<sub>GS</sub> = -10 V



## MARKING DIAGRAM & PIN ASSIGNMENT





E3P03 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMS3P03R2	SOIC-8	2500/Tape & Reel
NTMS3P03R2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	-30	٧
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±20	V
Thermal Resistance – Junction-to-Ambient (Note 1) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Pulsed Drain Current (Note 4)	R <sub>0JA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>D</sub>	171 0.73 -2.34 -1.87 -8.0	°C/W W A A
Thermal Resistance – Junction-to-Ambient (Note 2) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Pulsed Drain Current (Note 4)	R <sub>eJA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	100 1.25 -3.05 -2.44 -12	°C/W W A A
Thermal Resistance – Junction-to-Ambient (Note 3) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Pulsed Drain Current (Note 4)	R <sub>0JA</sub> PD I <sub>D</sub> I <sub>D</sub>	62.5 2.0 -3.86 -3.1 -15	°C/W W A A
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J$ = 25°C ( $V_{DD}$ = -30 Vdc, $V_{GS}$ = -4.5 Vdc, Peak $I_L$ = -7.5 Apk, L = 5 mH, $R_G$ = 25 $\Omega$ )	E <sub>AS</sub>	140	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T <sub>L</sub>	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Minimum FR-4 or G-10 PCB, t = steady state.

- Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t = steady state.
   Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.
- 4. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (Note 5)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = -250 \mu\text{Adc})$ Temperature Coefficient (Positive)			-30 -	- -30	- -	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = -30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = (V_{DS} = -30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 0 \text{ Vdc}, T_J = 0 \text{ Vdc}$	25°C) 125°C)	I <sub>DSS</sub>	- -	-	-1.0 -10	μAdc
Gate-Body Leakage Current (V <sub>GS</sub> = -20 Vdc, V <sub>DS</sub> = 0 Vdc)		I <sub>GSS</sub>	-	-	-100	nAdc
Gate-Body Leakage Current (V <sub>GS</sub> = +20 Vdc, V <sub>DS</sub> = 0 Vdc)		I <sub>GSS</sub>	-	-	100	nAdc
ON CHARACTERISTICS						
Gate Threshold Voltage ( $V_{DS} = V_{GS}$ , $I_{D} = -250  \mu Adc$ ) Temperature Coefficient (Negative)		V <sub>GS(th)</sub>	-1.0 -	-1.7 3.6	-2.5 -	Vdc
Static Drain-to-Source On-State Resistance ( $V_{GS}$ = -10 Vdc, $I_D$ = -3.05 Adc) ( $V_{GS}$ = -4.5 Vdc, $I_D$ = -1.5 Adc)		R <sub>DS(on)</sub>	- -	0.063 0.090	0.085 0.115	Ω
Forward Transconductance (V <sub>DS</sub> =	-15 Vdc, I <sub>D</sub> = -3.05 Adc)	9FS	-	5.0	-	Mhos
DYNAMIC CHARACTERISTICS					•	•
Input Capacitance		C <sub>iss</sub>	-	520	750	pF
Output Capacitance	$(V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	-	170	325	
Reverse Transfer Capacitance		C <sub>rss</sub>	-	70	135	
SWITCHING CHARACTERISTICS (	Notes 6 & 7)				•	•
Turn-On Delay Time		t <sub>d(on)</sub>	-	12	22	ns
Rise Time	$(V_{DD} = -24 \text{ Vdc}, I_D = -3.05 \text{ Adc},$	t <sub>r</sub>	-	16	30	
Turn-Off Delay Time	$V_{GS}$ = -10 Vdc, $R_G$ = 6.0 $\Omega$ )	t <sub>d(off)</sub>	-	45	80	
Fall Time		t <sub>f</sub>	-	45	80	
Turn-On Delay Time		t <sub>d(on)</sub>	-	16	-	ns
Rise Time	$(V_{DD} = -24 \text{ Vdc}, I_{D} = -1.5 \text{ Adc},$	t <sub>r</sub>	-	42	-	1
Turn-Off Delay Time	$V_{GS}$ = -4.5 Vdc, $R_G$ = 6.0 $\Omega$ )	t <sub>d(off)</sub>	-	32	-	
Fall Time		t <sub>f</sub>	-	35	-	1
Total Gate Charge	04 04 1/1-	Q <sub>tot</sub>	-	16	25	nC
Gate-Source Charge	$V_{DS} = -24 \text{ Vdc},$ $V_{GS} = -10 \text{ Vdc},$	Q <sub>gs</sub>	-	2.0	-	1
Gate-Drain Charge	$I_D = -3.05 \text{ Adc}$	Q <sub>gd</sub>	-	4.5	-	1
BODY-DRAIN DIODE RATINGS (N	ote 6)			1	l .	1
Diode Forward On-Voltage	$(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ V})$ $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C})$	V <sub>SD</sub>	-	-0.96 -0.78	-1.25 -	Vdc
Reverse Recovery Time		t <sub>rr</sub>	_	34	-	ns
	$(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A}/\mu\text{s})$	t <sub>a</sub>	-	18	-	
	2.5/dt = 100 / 4/kg)	t <sub>b</sub>	-	16	-	1
	Reverse Recovery Stored Charge					

Handling precautions to protect against electrostatic discharge is mandatory.
 Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.
 Switching characteristics are independent of operating junction temperature.

#### TYPICAL ELECTRICAL CHARACTERISTICS

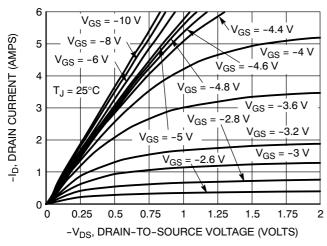
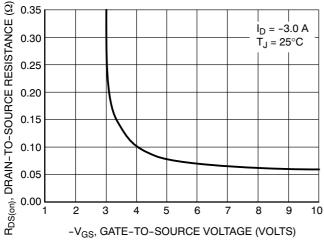


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



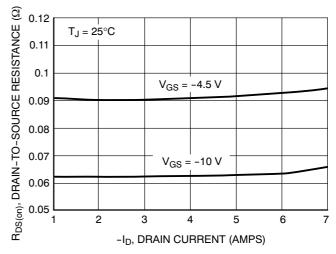


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

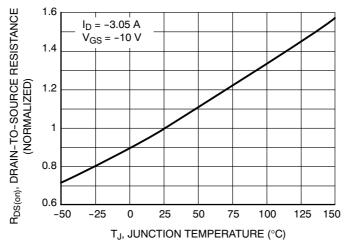
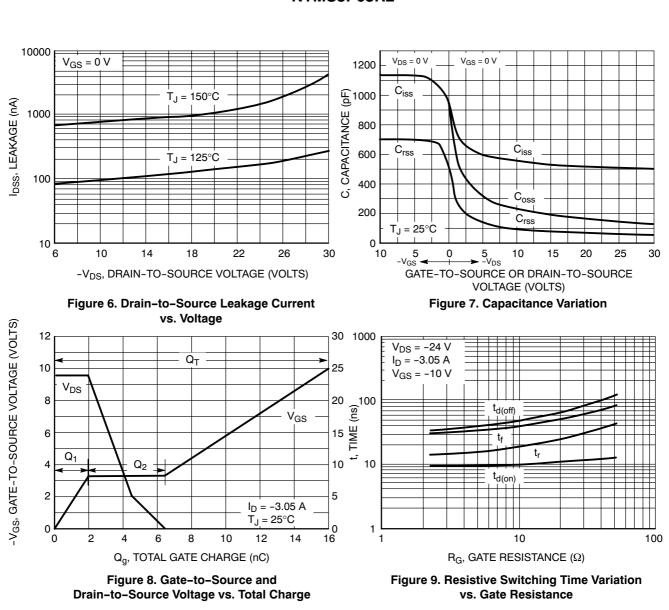


Figure 5. On Resistance Variation with Temperature



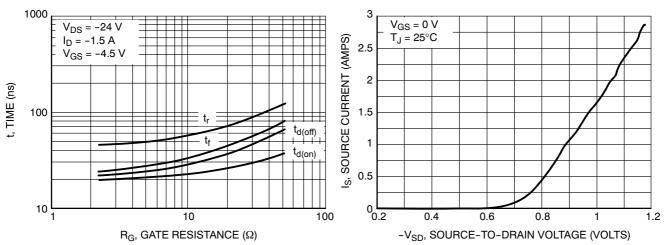
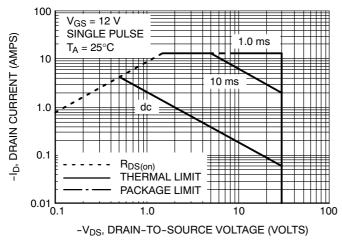


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

Figure 11. Diode Forward Voltage vs. Current



 $\begin{array}{c|c} I_{S} & & \\ \hline & t_{rr} \\ \hline & t_{a} & t_{b} \\ \hline & & \\ & &$ 

Figure 12. Maximum Rated Forward Biased Safe Operating Area

Figure 13. Diode Reverse Recovery Waveform

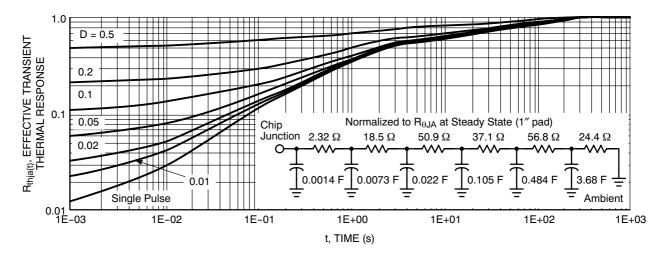
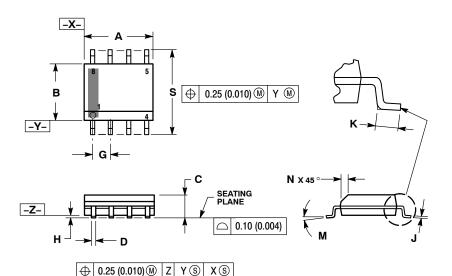


Figure 14. FET Thermal Response



SOIC-8 NB CASE 751-07 **ISSUE AK** 

**DATE 16 FEB 2011** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

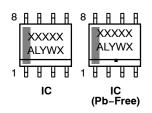
	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
C	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010	
J	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
M	0 °	8 °	0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

#### **SOLDERING FOOTPRINT\***



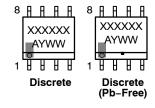
<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code = Assembly Location = Wafer Lot = Year = Work Week

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

#### **STYLES ON PAGE 2**

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#### SOIC-8 NB CASE 751-07 ISSUE AK

#### DATE 16 FEB 2011

			27112 101 22 2
STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 8. COLLECTOR, #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	8. DHAIN 1  STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
6. VEE 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	a COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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